

Reliability Monitoring Results

Quarters: Q1/2022 to Q4/2022 Based on structural similarity

Process family: Super micron Package family: TSSOP

Supplier User Part Number

Nexperia B.V. 74HC368PW Part Description: Hex inverter/line driver (3-state)

Function Family: HC(T)

JESD47 Test Test Conditions Duration # Lots # Quantity Rejects **TEST** see # 1 Pre- and Post-Stress Tamb = 25 °C N/A see below all parts below **Electrical Test** JESD22-A113 PC 83683 # 2 1070 0 N/A Preconditioning MSL 1 **HTOL EFR** JESD22-A108 48 hours # 5a High Temperature Ti = 150°C 63 23993 0 or Operating Life Extrinsic $V_{CCMAX} \le V \le 1.2*V_{CCMAX}$ 168 hours JESD22-A108 **HTOL IFR** # 5b High Temperature $T_j = 150$ °C ≥500 hours 59 3272 0 Operating Life Intrinsic $V_{CCMAX} \le V \le 1.2*V_{CCMAX}$ JESD22-A104 # 7 0 ≥500 cycles 549 43127 Temperature Cycling -65 °C to 150°C uHAST / HAST JESD22-A101 unbiased or biased High Tamb = $130 \, ^{\circ}$ C, # 9 96 hours 521 40556 0 Accelerated Stress Test RH = 85%, $V = V_{CCMAX}$

Calculation of PPM, FIT and MTTF

Test considered for PPM calculation: High Temperature Operating LifeTest Extrinsic (HTOL EFR, Test # 5a above) Test considered for FIT and MTTF calculations: High Temperature Operating LifeTest Intrinsic(HTOL IFR, Test # 5b above)

Confidence level 60%, derated to 55 °C, activation energy 0.7 eV, test time 168 to 1000 hours

Product Family	Package Family	Quantity	Rejects	Extrinsic Failure Rate (PPM)	Intrinsic Failure Rate (FIT)	MTTF (hrs)
HC(T)	TSSOP	3272	0	39	1.2	8.84 E+08